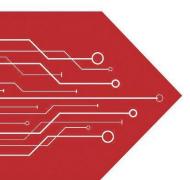
MSKSEMI















ESD

TVS

TSS

MOV

GDT

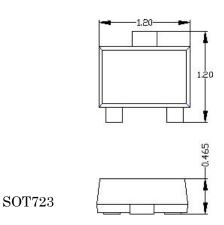
PLED

Product data sheet

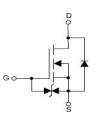
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High Density Cell Design for Low RDS(ON) Voltage Controlled Small Signal Switch Small Outline Surface Mount Package RoHS compliant / Green EMC







ELECTRICAL CHARACTERISTICS @ 25° C Unless Otherwise Specified

Symbo1	Parameter	Test Conditions	Min	Тур	Max	Units
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V, I_D =250 μ A	60			V
$V_{GS(th)}$	Gate-Threshold Voltage	V _{DS} =VGS, I _D =250μA	1.0	1.4	2.5	V
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =48V, V_{GS} =0V			1. 0	uA
\mathbf{I}_{GSS}	Gate-Body Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±10	μΑ
		$V_{GS}=\pm 10V$, $V_{DS}=0V$			±200	nA
		$V_{GS}=\pm 5V$, $V_{DS}=0V$			±100	nA

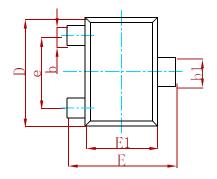


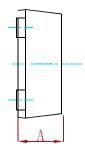
MAXIMUM RATINGS (Ta=25°C unless otherwise noted)

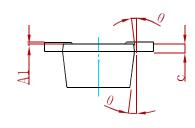
Symbol	Parameter	Value	Unit
$V_{ m DS}$	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	±20	V
V _{EBO}	Emitter-Base Voltage	6	V
I_{D}	Drain Current-Continuous	0.34	A
P_{D}	Power Dissipation	0.15	W
Р Ө ЈА	Thermal Resistance From Junction To Ambient	833	°C/W
Тj	Junction Temperature	150	$^{\circ}\!\mathbb{C}$
Tstg	Storage Temperature	-55~+150	$^{\circ}$

R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =10V, I _D =500mA		1.3	4.0		
		V _{GS} =4.5V,I _D =200mA		1.4	4.5	Ω	
Q _r	Recovered Charge	V_{GS} =0V, I_{S} =300mA, V_{R} =25V dI/dt=-100A/ μ s		30		nC	
Dynamic	Characteristics						
C _{iss}	Input Capacitance				40		
C _{oss}	Output Capacitance	V _{DS} =10V,V _{GS} =0V, f=1MHz			30	pF	
C _{rss}	Reverse Transfer Capacitance				10		
Switchin	g Characteristics			,			
t _{d(on)}	Turn-on Delay Time	V_{DD} =25V, V_{GS} =10V, R_L =250 Ω ,			10		
$t_{d(off)}$	Turn-off Delay Time	R_{GS} =50K, R_{GEN} =25 Ω			15	nS	
t _{rr}	Reverse Recovery Time	V_{GS} =0V, I_{S} =300mA, V_{R} =25V, dI/dt =-100A/ μ s		30		113	
Source-Drain Diode Characteristics							
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =200mA		0.97	1.5	V	

PACKAGE MECHANICAL DATA

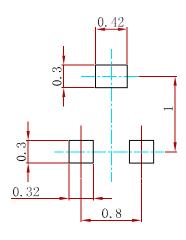






Cumhal	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	0.430	0.500	0.017	0.020	
A1	0.000	0.050	0.000	0.002	
b	0.170	0.270	0.007	0.011	
b1	0.270	0.370	0.011	0.015	
С	0.080	0.150	0.003	0.006	
D	1.150	1.250	0.045	0.049	
E	1.150	1.250	0.045	0.049	
E1	0.750	0.850	0.030	0.033	
е	0.800TYP.		0.031TYP.		
θ	7° REF.		7° REF.		

Suggested Pad Layout



Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
MS2N7002M3	SOT-723	8000



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